

Middle Power LED Series 301B

LM301B

CRI70



Features & Benefits

- 0.3 W class middle power LED
- Mold resin for high reliability
- Standard form factor for design flexibility (3.0 × 3.0 mm)



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1. Characteristics

a) Absolute Maximum Rating

Item	Symbol	Rating	Unit	Condition
Ambient / Operating Temperature	T_a	-40 ~ +85	°C	-
Storage Temperature	T_{stg}	-40 ~ +120	°C	-
LED Junction Temperature	T_j	110	°C	-
Forward Current	I_F	200	mA	-
Pulse Forward Current	I_{FP}	300	mA	Duty 1/10, pulse width 10ms
Assembly Process Temperature	-	260 <10	°C s	-
ESD (HBM)	-	5	kV	-

b) Electro-optical Characteristics ($I_F = 65 \text{ mA}$, $T_s = 25 \text{ °C}$)

Item	Unit	Rank	Bin	Min.	Typ.	Max.
Forward Voltage (V_F)	V	XA	AY	2.6	-	2.7
			AZ	2.7	-	2.8
			A1	2.8	-	2.9
Reverse Voltage (@ 5 mA)	V			0.7	-	1.2
Color Rendering Index (R_a)	-			70	-	-
Thermal Resistance (junction to solder point)	°C/W			-	7.5	-
Beam Angle	°			-	120	-

Note:

Samsung maintains measurement tolerance of: forward voltage = $\pm 0.1 \text{ V}$, luminous flux = $\pm 5 \%$, CRI = ± 3

c) Electro-optical Characteristics ($T_s = 25\text{ }^{\circ}\text{C}$)

Item	CRI	Nominal CCT (K)	SJ		SK		SL		SM		Current
			Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
			34	36	36	38	38	40	40	42	65mA
Luminous Flux (Φ_v)	70	3000									
		3500									
		4000									
		5000									

Note:

Samsung maintains measurement tolerance of: forward voltage = $\pm 0.1\text{V}$, luminous flux = $\pm 5\%$, CRI = ± 3

a) Luminous Flux Bins ($I_F = 65 \text{ mA}$, $T_s = 25^\circ\text{C}$)



CRI (R _a) Min.	Nominal CCT (K)	Product Code	Flux Bin	Flux Range (Φ _v , lm)
70	3000	SPMWH32AMD3XAV●S0	SJ	34.0 ~ 36.0
			SK	36.0 ~ 38.0
			SL	38.0 ~ 40.0
	3500	SPMWH32AMD3XAU●S0	SJ	34.0 ~ 36.0
			SK	36.0 ~ 38.0
			SL	38.0 ~ 40.0
	4000	SPMWH32AMD3XAT●S0	SK	36.0 ~ 38.0
			SL	38.0 ~ 40.0
			SM	40.0 ~ 42.0
	5000	SPMWH32AMD3XAR●S0	SK	36.0 ~ 38.0
			SL	38.0 ~ 40.0
			SM	40.0 ~ 42.0

Note:

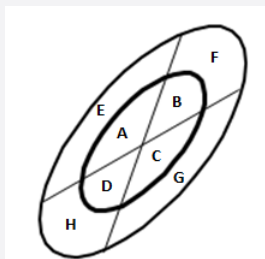
"●" can be "0" (Whole bin), "K" (K Kitting) or "S" (S Kitting) of the color binning

b) Kitting Rule

1) S Kitting Bin Concept

1. Under agreement between customer and SAMSUNG ELECTRONICS, SAMSUNG can supply kitting bin (VF, Color, lm).
2. A forward voltage (VF) of kitting bin is combined by a pair of same VF rank such as (AY+AY), (AZ+AZ) or (A1+A1)
3. A Chromaticity Coordinates of kitting bin is mixed by kitting procedure.(below kitting simulation)
4. A luminous flux(lm) of kitting bin is combined by a pair of IV rank such as (SJ+SJ), (SJ+SK), (SK+SK), (SK+SL), (SL+SL), (SL+SM) or (SM+SM)

[Kitting example]



[Binning Information]

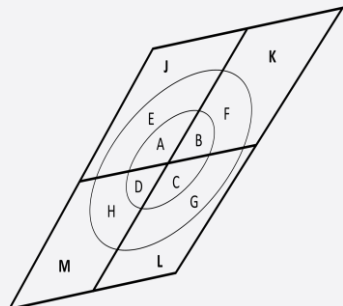
	Bin #1	Bin #2	Remark
VF	AY	AY	
	AZ	AZ	
	A1	A1	
CIE	A	G	
	C	E	
	D	F	
	B	H	
	E	G	
	F	H	
	3 (A, B, C, D)	3 (A, B, C, D)	
IV	SJ	SJ	
	SJ	SK	
	SK	SK	
	SK	SL	
	SL	SL	
	SL	SM	
	SM	SM	

2) K Kitting Bin Concept

1. Under agreement between customer and SAMSUNG ELECTRONICS, SAMSUNG can supply kitting bin (VF, Color, lm).

2. A forward voltage (VF) of kitting bin is combined by a pair of same VF rank such as (AY+AY), (AY+AZ), (AZ+AZ), (AZ+A1) or (A1+A1)
3. A Chromaticity Coordinates of kitting bin is mixed by kitting procedure.(below kitting simulation)
4. A luminous flux(lm) of kitting bin is combined by a pair of IV rank such as (SE+SE), (SE+SF), (SF+SF), (SF+SG), (SG+SG)

[Kitting example]



[Binning Information]

	Bin #1	Bin #2	Remark
VF	AY	AY	
	AY	AZ	
	AZ	AZ	
	AZ	A1	
	A1	A1	
CIE	H	K	
	F	M	
	E	L	
	G	J	
	E	G	
	F	H	
	MacA. 3step(A, B, C, D)	MacA. 3step(A, B, C, D)	
IV	SJ	SJ	
	SJ	SK	
	SK	SK	
	SK	SL	
	SL	SL	
	SL	SM	
	SM	SM	

c) Color Bins ($I_f = 65 \text{ mA}$, $T_s = 25^\circ\text{C}$)

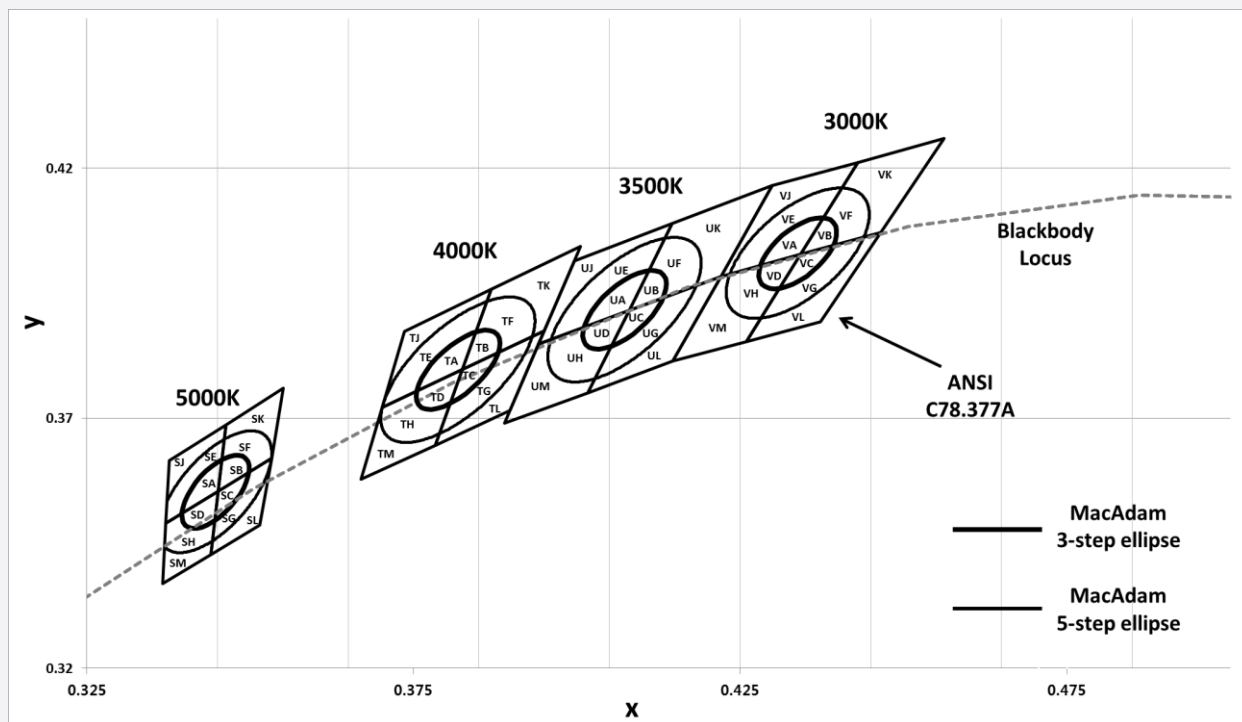
CRI (Ra) Min.	Nominal CCT (K)	Product Code	Color Rank	Chromaticity Bins
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70	3000	SPMWHD32AMD3XAV0S0	V0 (Whole bin)	VA, VB, VC, VD, VE, VF, VG, VH, VJ, VK, VL, VM
		SPMWHD32AMD3XAVSS0	VS (S Kitting)	VA, VB, VC, VD, VE, VF, VG, VH
		SPMWHD32AMD3XAVKS0	VK (K Kitting)	VA, VB, VC, VD, VE, VF, VG, VH, VJ, VK, VL, VM
	3500	SPMWHD32AMD3XAU0S0	U0 (Whole bin)	UA, UB, UC, UD, UE, UF, UG, UH, UJ, UK, UL, UM
		SPMWHD32AMD3XAUSS0	US (S Kitting)	UA, UB, UC, UD, UE, UF, UG, UH
		SPMWHD32AMD3XAUKS0	UK (K Kitting)	UA, UB, UC, UD, UE, UF, UG, UH, UJ, UK, UL, UM
	4000	SPMWHD32AMD3XAT0S0	T0 (Whole bin)	TA, TB, TC, TD, TE, TF, TG, TH, TJ, TK, TL, TM
		SPMWHD32AMD3XATSS0	TS (S Kitting)	TA, TB, TC, TD, TE, TF, TG, TH
		SPMWHD32AMD3XATKS0	TK (K Kitting)	TA, TB, TC, TD, TE, TF, TG, TH, TJ, TK, TL, TM
	5000	SPMWHD32AMD3XAR0S0	R0 (Whole bin)	RA, RB, RC, RD, RE, RF, RG, RH RJ,RK,RL,RM
		SPMWHD32AMD3XARSS0	RS (S Kitting)	RA, RB, RC, RD, RE, RF, RG, RH
		SPMWHD32AMD3XARKS0	RK (K Kitting)	RA, RB, RC, RD, RE, RF, RG, RH RJ,RK,RL,RM

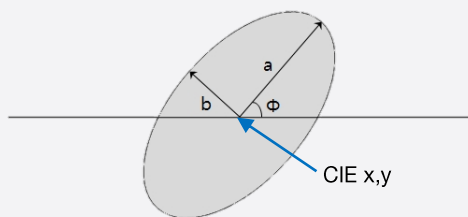
d) Voltage Bins ($I_F = 65 \text{ mA}$, $T_s = 25^\circ\text{C}$)

CRI (Ra) Min.	Nominal CCT (K)	Product Code	Voltage Rank	Voltage Bin	Voltage Range (V)
-	-	-	XA	AY	2.6 ~ 2.7
				AZ	2.7 ~ 2.8
				A1	2.8 ~ 2.9

e) Chromaticity Region & Coordinates ($I_F = 65 \text{ mA}$, $T_s = 25^\circ\text{C}$)



f) Chromaticity Region & Coordinates ($I_F = 65 \text{ mA}$, $T_s = 25^\circ\text{C}$)



MacAdam Ellipse (V3, V5)					
Step	CIE x	CIE y	θ	a	b
3-step	0.4338	0.4030	53.22	0.0083	0.0041
5-step	0.4338	0.4030	53.22	0.01390	0.00680

MacAdam Ellipse (U3, U5)					
Step	CIE x	CIE y	θ	a	b
3-step	0.4073	0.3917	54.00	0.00927	0.00414
5-step	0.4073	0.3917	54.00	0.01545	0.00690

MacAdam Ellipse (T3, T5)					
Step	CIE x	CIE y	θ	a	b
3-step	0.3818	0.3797	53.72	0.00939	0.00402
5-step	0.3818	0.3797	53.72	0.01565	0.00670

MacAdam Ellipse (R3, R5)					
Step	CIE x	CIE y	θ	a	b
3-step	0.3447	0.3553	59.62	0.0082	0.0035
5-step	0.3447	0.3553	59.62	0.01370	0.00590

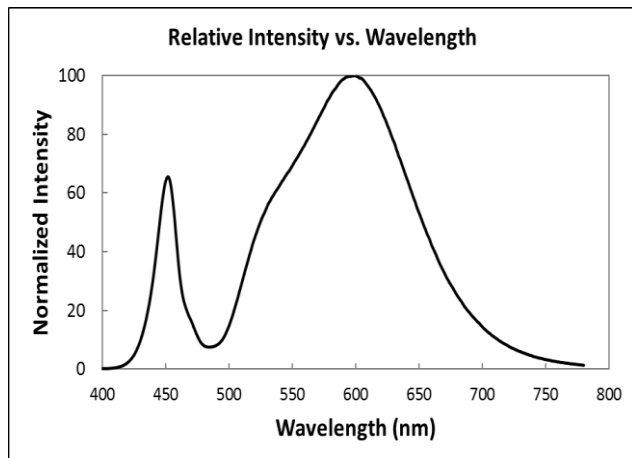
Note:

Samsung maintains measurement tolerance of: $C_x, C_y = \pm 0.005$

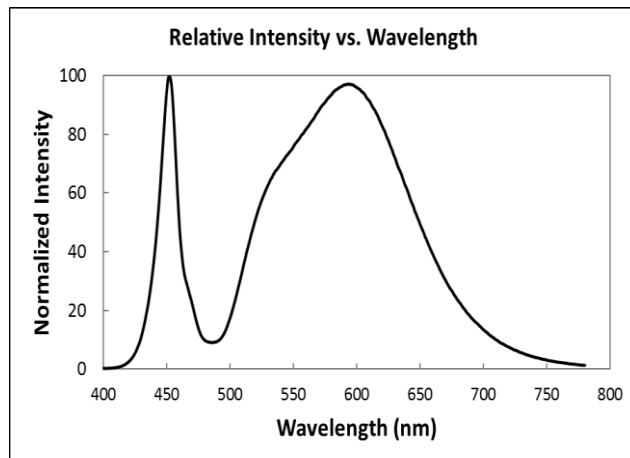
3. Typical Characteristics Graphs

a) Spectrum Distribution ($I_f = 65 \text{ mA}$, $T_s = 25^\circ \text{C}$)

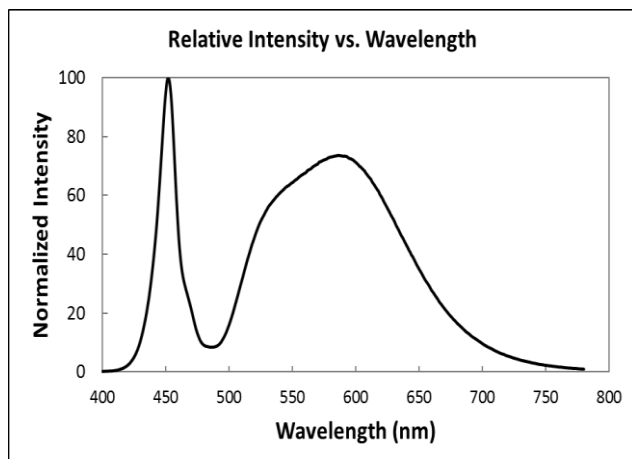
CCT : 3000K (70 CRI)



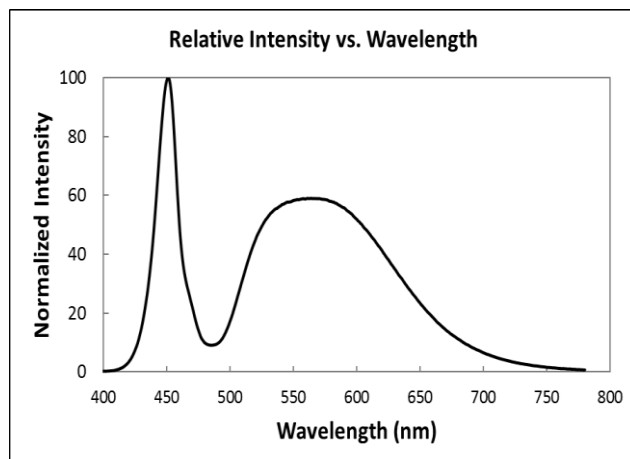
CCT : 3500K (70 CRI)



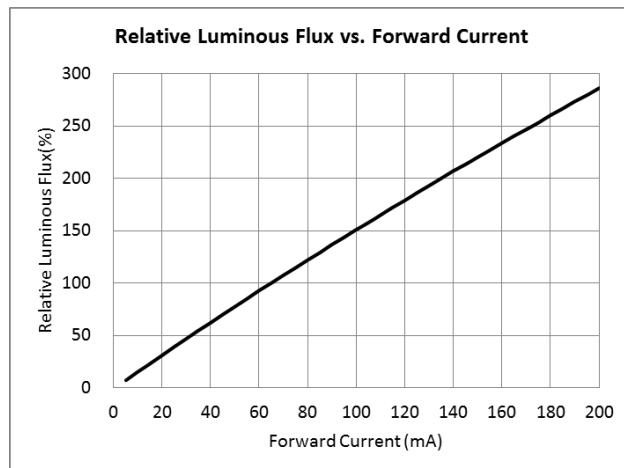
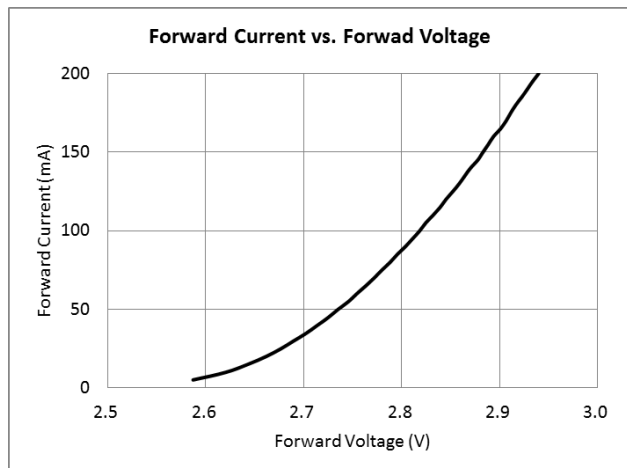
CCT : 4000K (70 CRI)



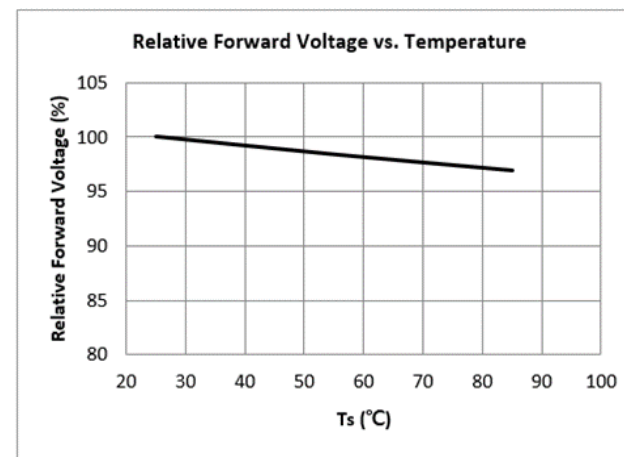
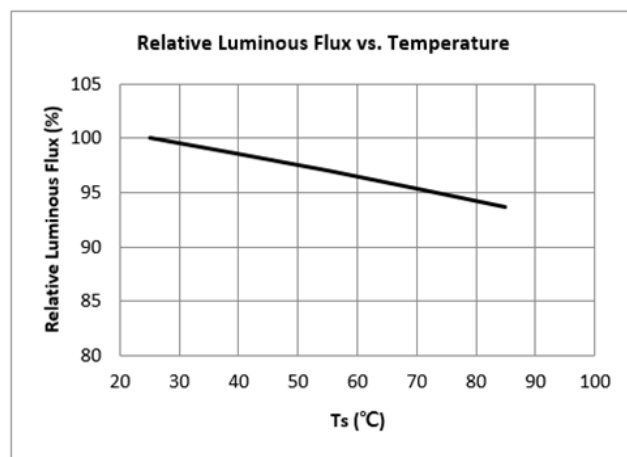
CCT : 5000K (70 CRI)



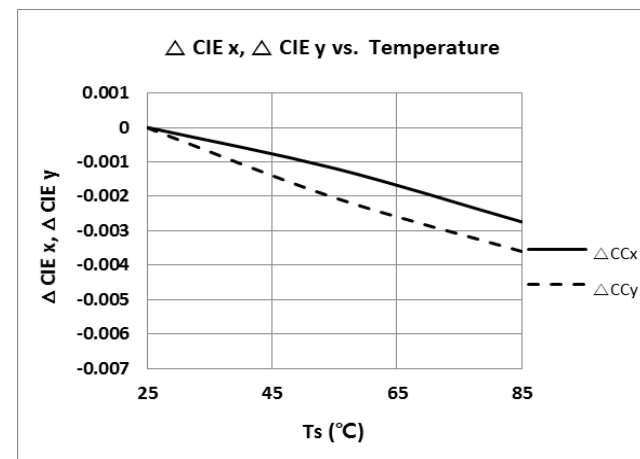
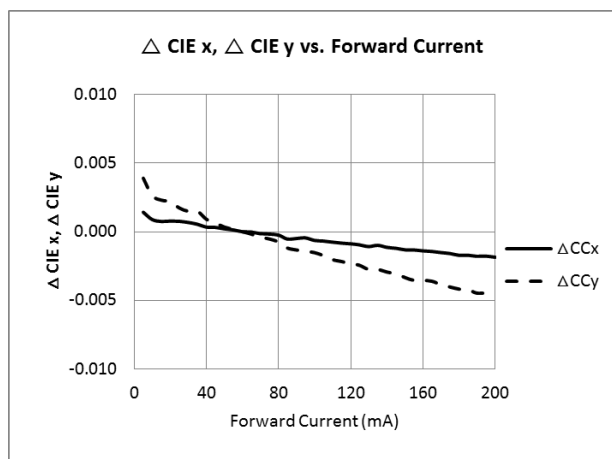
b) Forward Current Characteristics ($T_s = 25^\circ\text{C}$)



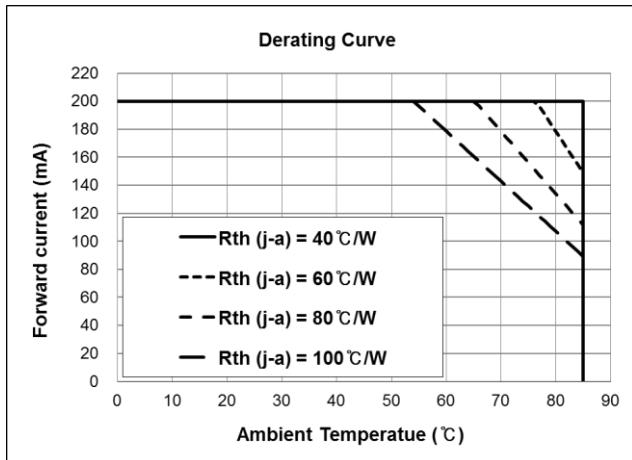
c) Temperature Characteristics ($I_F = 65\text{ mA}$)



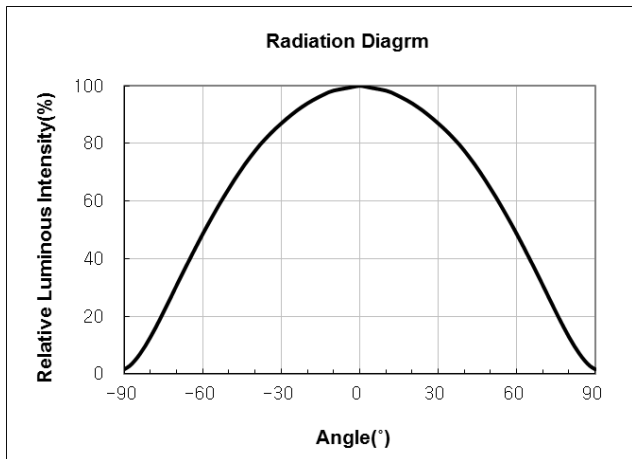
d) Color Shift Characteristics, $T_s = 25^\circ\text{C}$, $I_F = 65\text{ mA}$



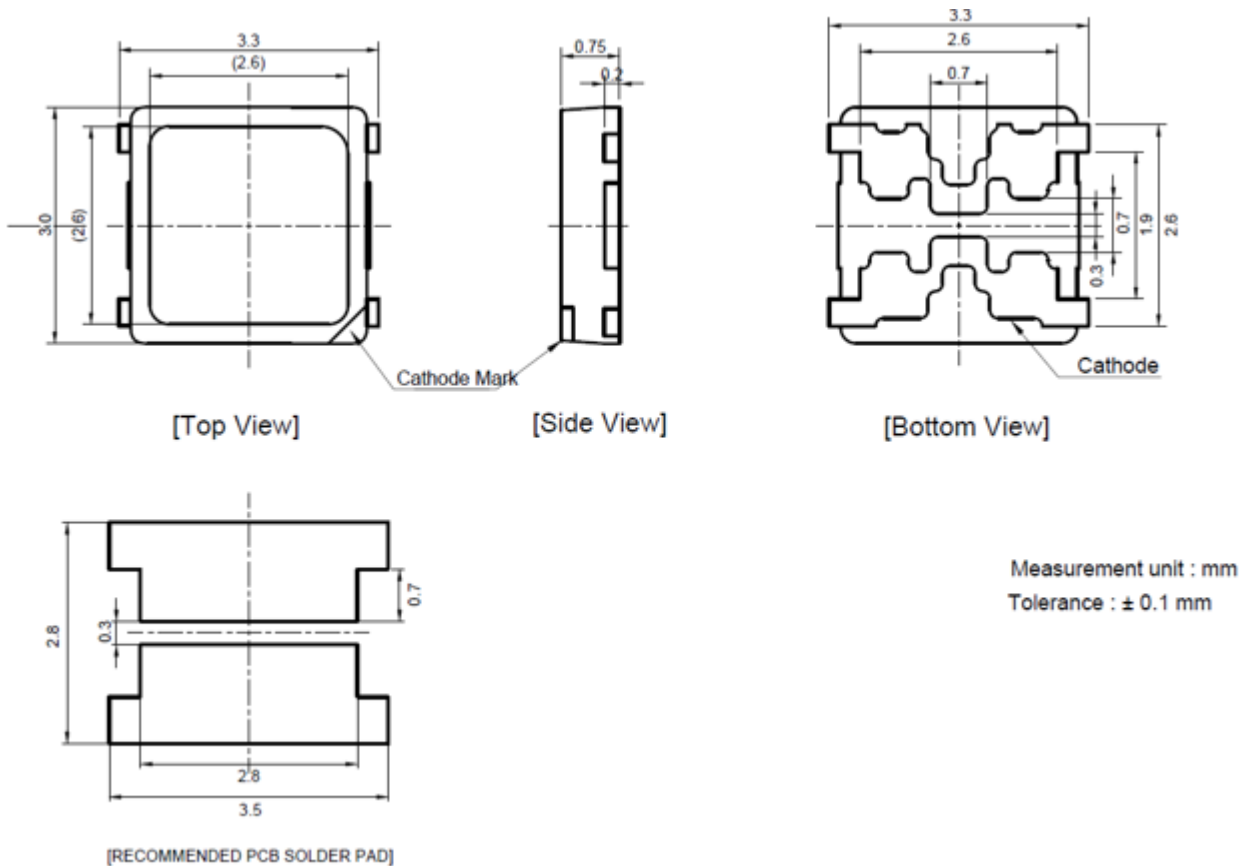
e) Derating Curve



f) Beam Angle Characteristics ($T_s = 25\text{ }^{\circ}\text{C}$, $I_f = 65\text{ mA}$)



4. Outline Drawing & Dimension



Notes:

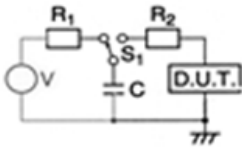
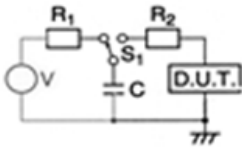
- 1) This LED has built-in ESD protection device(s) connected in parallel to LED chip(s).
- 2) T_s point and measurement method:
 - ① Measure one point at the cathode pad, if necessary remove PSR of PCB to reach T_s point.
 - ② All pads must be soldered to the PCB to dissipate heat properly, otherwise the LED can be damaged.

Precautions:

- 1) Pressure on the LEDs will influence to the reliability of the LEDs. Precautions should be taken to avoid strong pressure on the LEDs. Do not put stress on the LEDs during heating.
- 2) Re-soldering should not be done after the LEDs have been soldered. If re-soldering is unavoidable, LED's characteristics should be carefully checked before and after such repair.
- 3) Do not stack assembled PCBs together. Since materials of LEDs is soft, abrasion between two PCB assembled with LED might cause catastrophic failure of the LEDs.

5. Reliability Test Items & Conditions

a) Test Items

Test Item	Test Condition	Test Hour / Cycle	Sample No.
Room Temperature Life Test	25 °C, DC 200 mA	1000 h	22
High Temperature Life Test	85 °C, DC 200 mA	1000 h	22
High Temperature Humidity Life Test	85 °C, 85 % RH, DC 200 mA	1000 h	22
Low Temperature Life Test	-40 °C, DC 200 mA	1000 h	22
Powered Temperature Cycle Test	-40 °C ~ 85 °C, each 10 min, On/Off 5min , Temp. Change Time 20min, DC 200 mA	100 cycles	22
Thermal Cycle	-45 °C / 15 min ↔ 125 °C / 15 min → Hot plate 180 °C	500 cycles	100
High Temperature Storage	120 °C	1000 h	11
Low Temperature Storage	-40 °C	1000 h	11
ESD (HBM)	<div></div> <div>R₁: 10 MΩ R₂: 1.5 kΩ C: 100 pF V: ±5 kV</div>	5 times	30
ESD (MM)	<div></div> <div>R₁: 10 MΩ R₂: 0 C: 200 pF V: ±0.5 kV</div>	5 times	30
Vibration Test	20~2000~20 Hz, 200 m/s ² , sweep 4 min X, Y, Z 3 direction, each 1 cycle	4 cycles	11
Mechanical Shock Test	1500 g, 0.5 ms 3 shocks each X-Y-Z axis	5 cycles	11

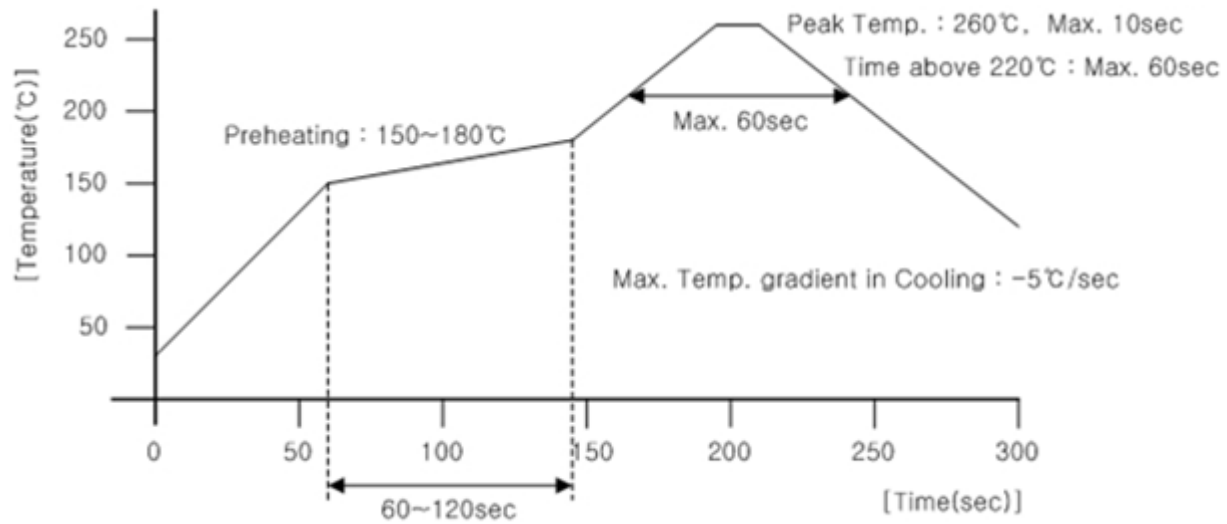
b) Criteria for Judging the Damage

Item	Symbol	Test Condition (T _s = 25 °C)	Limit	
			Min	Max
Forward Voltage	V _F	I _F = 65 mA	Init. Value * 0.9	Init. Value * 1.1
Luminous Flux	Φ _v	I _F = 65 mA	Init. Value * 0.7	Init. Value * 1.1

6. Soldering Conditions

a) Reflow Conditions (Pb free)

Reflow frequency: 2 times max.



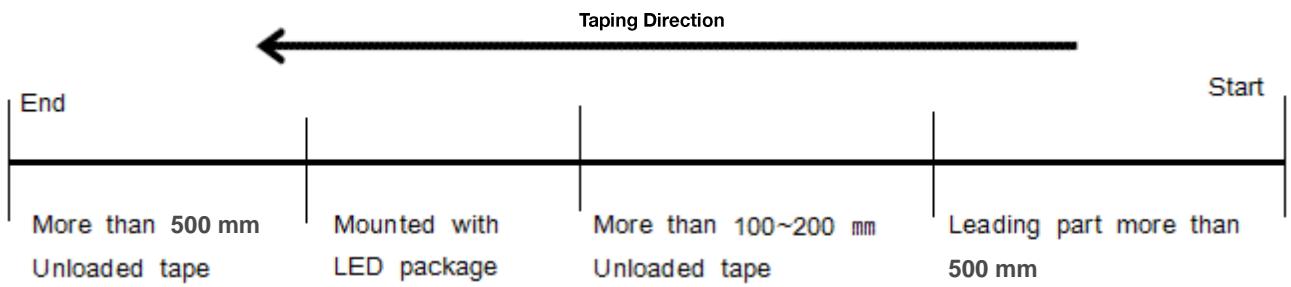
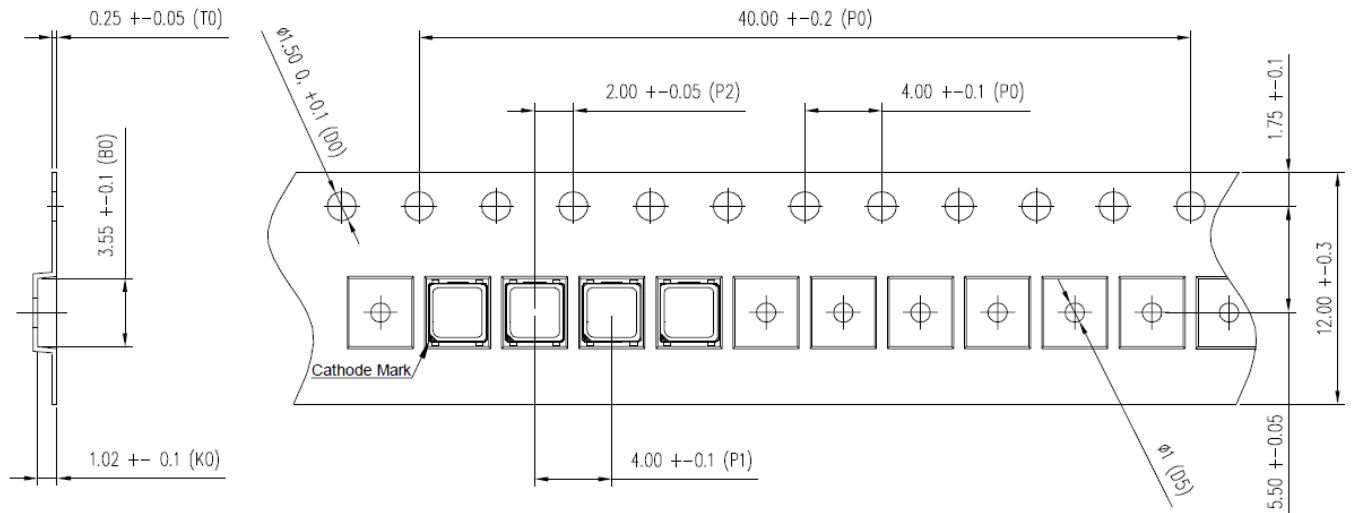
b) Manual Soldering Conditions

Not more than 5 seconds @ max. 300 °C, under soldering iron.

7. Tape & Reel

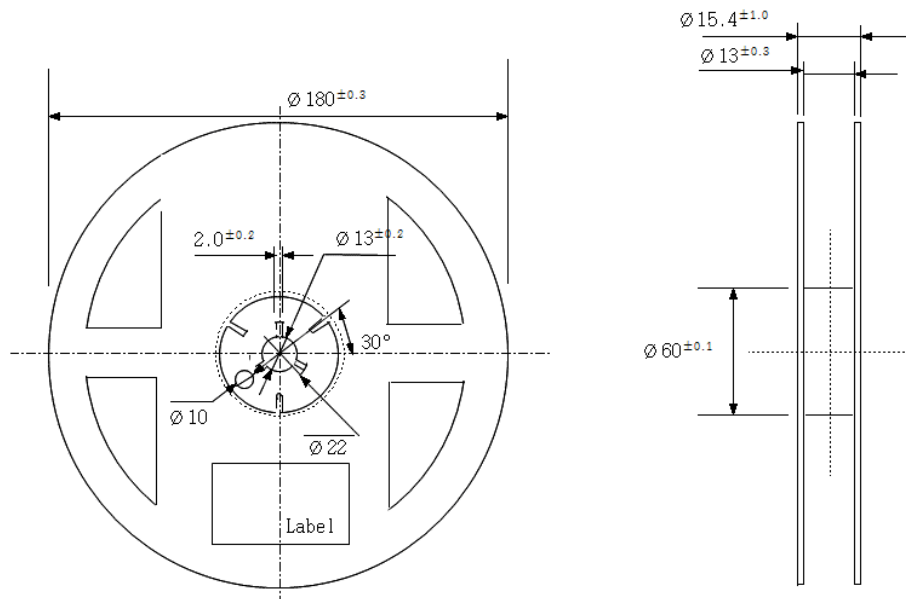
a) Taping Dimension

(unit: mm)



b) Reel Dimension

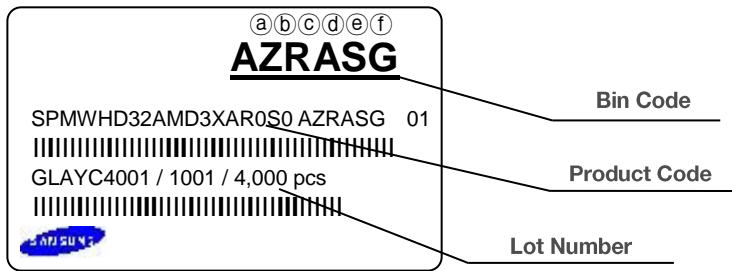
(unit: mm)

**Notes:**

- 1) Quantity: The quantity/reel is 4,000 pcs
- 2) Cumulative Tolerance: Cumulative tolerance / 10 pitches is ± 0.2 mm
- 3) Adhesion Strength of Cover Tape: Adhesion strength is 0.1-0.7 N when the cover tape is turned off from the carrier tape at 10° angle to the carrier tape
- 4) Packaging: P/N, Manufacturing data code no. and quantity are indicated on the aluminum packing bag

8. Label Structure

a) Label Structure



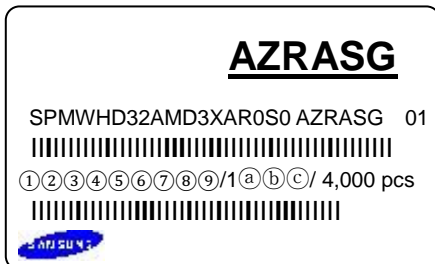
Note: Denoted bin code and product code above is only an example (see description on page 5)

Bin Code:

- ⒶⒷ: Forward Voltage bin (refer to page 8)
- ⒸⒹ: Chromaticity bin (refer to page 10-13)
- ⒺⒻ: Luminous Flux bin (refer to page 8)

b) Lot Number

The lot number is composed of the following characters:



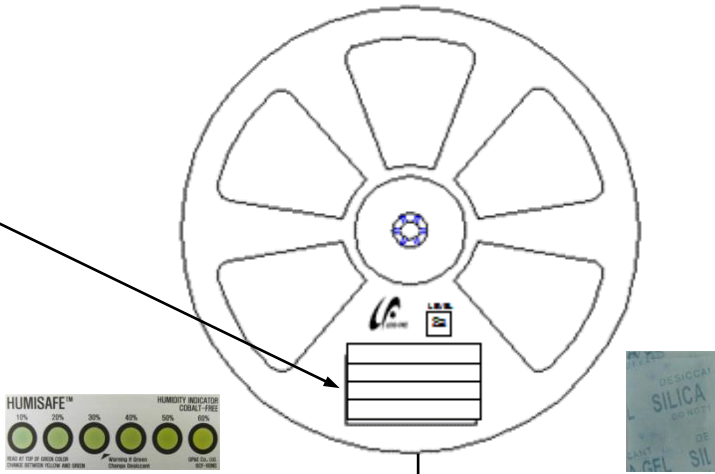
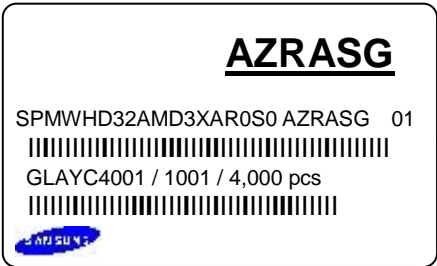
① ②③④⑤⑥⑦⑧⑨ / 1ⒶⒷⒸ / 4,000 pcs

- ① : Production site (S: Giheung, Korea, G: Tianjin, China)
- ② : L (LED)
- ③ : Product state (A: Normal, B: Bulk, C: First Production, R: Reproduction, S: Sample)
- ④ : Year (Z: 2015, A: 2016, B: 2017...)
- ⑤ : Month (1~9, A, B, C)
- ⑥⑦⑧⑨ : Day (1~9, A, B~V)
- ⒶⒷⒸ : Product serial number (001 ~ 999)

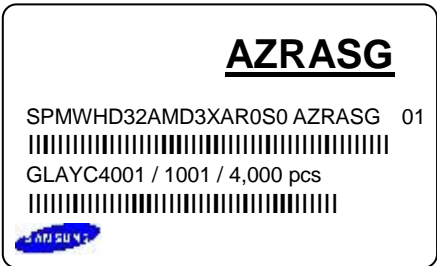
9. Packing Structure

a) Packing Process (The quantity of PKG on the Reel to be Max 4,000pcs)

Reel



Aluminum Vinyl Packing Bag

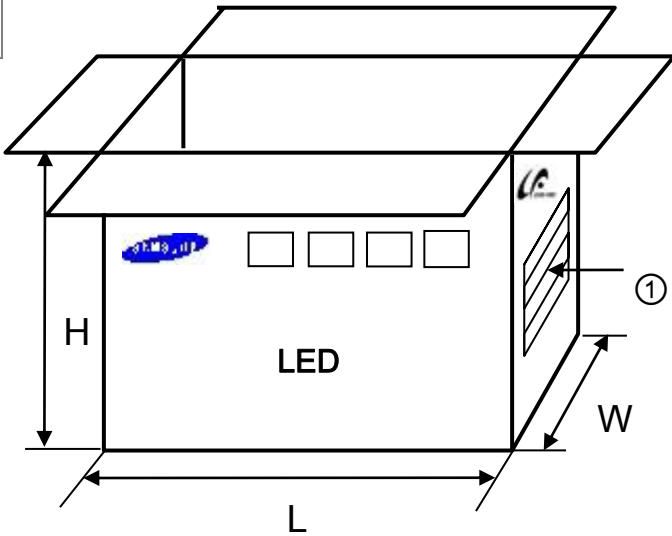
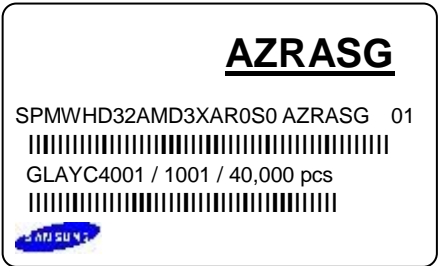


Outer Box

Material: Paper (SW3B(B))

Type	Size (mm)			Note
	L	W	H	
7 inch L	245 ± 5	220 ± 5	182 ± 5	Up to 10 reels
7 inch S	245 ± 5	220 ± 5	86 ± 5	Up to 5 reels

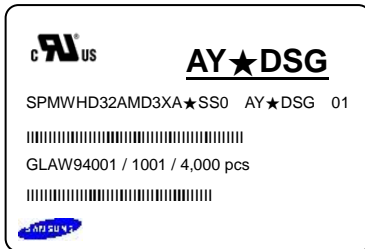
① Side Label



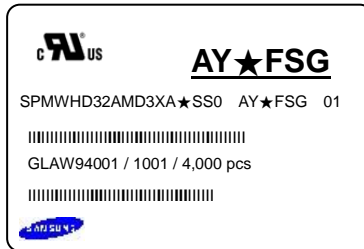
b) Packing Process for kitting (The quantity of PKG on the Reel to be Max 4,000pcs)

Reel

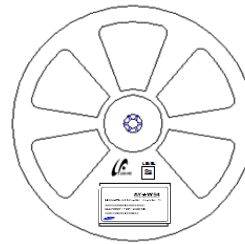
Kitting 'A'



Kitting 'B'



Kitting 'A'

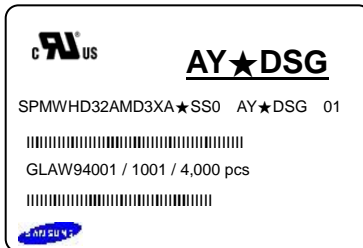


Kitting 'B'

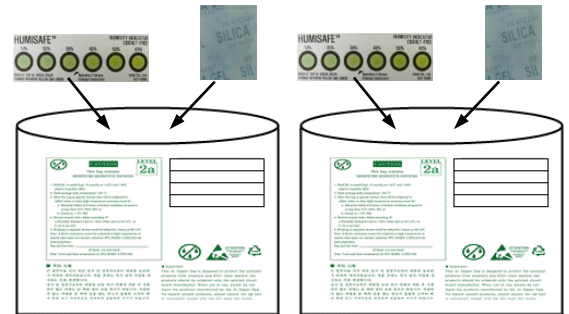
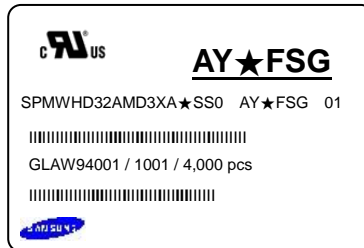


Aluminum Vinyl Packing Bag

Kitting 'A'

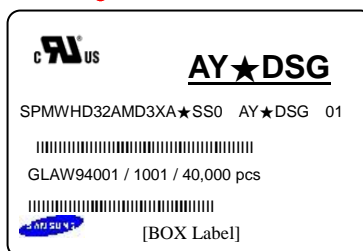


Kitting 'B'

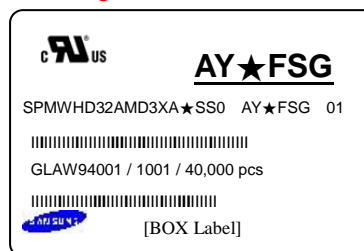


Outer Box

Kitting 'A'



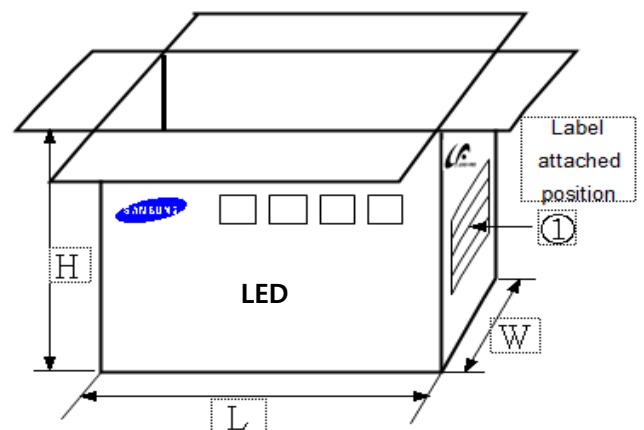
Kitting 'B'




Note: "★" can be Nominal CCT code.

Material: Paper (SW3B(B))

Type	Size (mm)			Note
	L	W	H	
7 inch L	245 ± 5	220 ± 5	182 ± 5	Up to 10 reels



c) Aluminum Vinyl Packing Bag



CAUTION

This bag contains
MOISTURE SENSITIVE DEVICES

LEVEL
2a

1. Shelf life in sealed bag: 12 months at <40℃ and <90% relative humidity (RH)
2. Peak package body temperature: 240 ℃
3. After this bag is opened, devices that will be subjected to reflow solder or other high temperature processes must be:
 - a. Mounted within 672 hours at factory conditions of equal to or less than 30℃ /60% RH, or
 - b. Stored at < 10% RH
4. Devices require bake, before mounting, if:
 - a. Humidity Indicator Card is >60% when read at 23±5℃, or
 - b. 2a is not met.
5. If baking is required, devices must be baked for 10 ~ 24 hours at 60±5℃





Note: If device containers cannot be subjected to high temperature or shorter bake times are desired, reference IPC/JEDEC J-STD-033 for bake procedure,

Bag seal due date: _____
(If blank, see code label)

Note: Level and body temperature by IPC/JEDEC J-STD-020

AZRASG

SPMWH32AMD3XAR0S0 AZRASG 01
 |||||
 GLAYC4001 / 1001 / 4,000 pcs
 |||||

■ 주의 사항

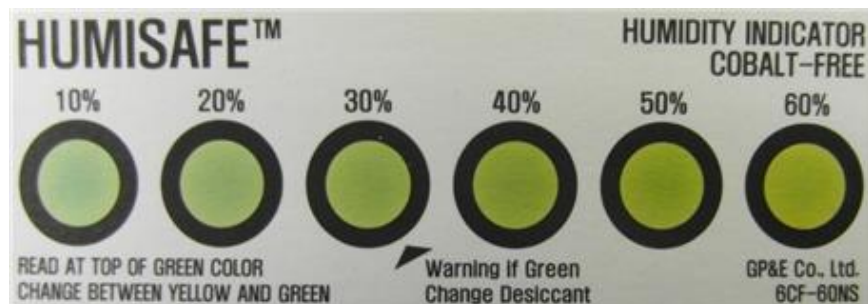
이 알루미늄 지퍼 백은 습기 및 정전기로부터 제품을 보호하기 위하여 제작되었습니다. 개봉 후에는 즉시 솔더 작업을 실시하는 것을 권장합니다.

습기 및 정전기로부터 제품을 보호 하기 위해서 개봉 후 사용하지 않는 자재는 본 팩에 넣어 보관 하시기 바랍니다. 사용하지 않는 자재를 본 팩에 넣을 때는 반드시 동봉된 드라이 팩과 함께 넣고 지퍼부분을 완전하게 밀봉하여 주시기 바랍니다.

■ Important

This Al Zipper bag is designed to protect the enclosed products from moisture and ESD. Once opened, the products should be soldered onto the printed circuit board immediately. When not in use, please do not leave the products unprotected by the Al Zipper Bag. To repack unused products., please ensure the zip-lock is completely sealed with the dry pack left inside.

c) Silica Gel & Humidity Indicator Card inside Aluminum Vinyl Bag



10. Precautions in Handling & Use

- 1) For over-current protection, users are recommended to apply resistors connected in series with the LEDs to mitigate sudden change of the forward current caused by shift of forward voltage.
- 2) This device should not be used in any type of fluid such as water, oil, organic solvent, etc. When cleaning is required, IPA is recommended as the cleaning agent. Some solvent-based cleaning agent may damage the silicone resins used in the device.
- 3) When the device is in operation, the forward current should be carefully determined considering the maximum ambient temperature and corresponding junction temperature.
- 4) LEDs must be stored in a clean environment. If the LEDs are to be stored for three months or more after being shipped from Samsung, they should be packed with a nitrogen-filled container (shelf life of sealed bags is 12 months at temperature 0~40 °C, 0~90 % RH).
- 5) After storage bag is opened, device subjected to soldering, solder reflow, or other high temperature processes must be:
 - a. Mounted within 672 hours (28 days) at an assembly line with a condition of no more than 30 °C / 60 % RH^{*Note 1}, or
 - b. Mounted within 24 hours (1 day) at an assembly line with a condition of more than 30 °C / 70 % RH^{*Note 2}, or
 - c. Stored at <10 % RH.

*Note 1, 2: IPC/JEDEC J-STD-033A, Recommended Equivalent Total Floor Life Table

Package Type and Body Thickness	Moisture Sensitivity Level	Maximum Percent Relative Humidity						Temperature
		40%	50%	60%	70%	80%	90%	
Body Thickness <2.1mm	Level 2a	∞	∞	28	1	1	1	30°C
		∞	∞	∞	2	1	1	25°C
		∞	∞	∞	2	2	1	20°C

- 6) Repack unused devices with anti-moisture packing, fold to close any opening and then store in a dry place.
- 7) Devices require baking before mounting, if humidity card reading is >60 % at 23 ± 5 °C.
- 8) Devices must be baked for 10~24 hours at 60 ± 5 °C, if baking is required.
- 9) The LEDs are sensitive to the static electricity and surge current. It is recommended to use a wrist band or anti-electrostatic glove when handling the LEDs. If voltage exceeding the absolute maximum rating is applied to LEDs, it may cause damage or even destruction to LED devices. Damaged LEDs may show some unusual characteristics such as increase in leakage current, lowered turn-on voltage, or abnormal lighting of LEDs at low current.
- 10) VOCs (Volatile Organic Compounds) can be generated from adhesives, flux, hardener or organic additives used in luminaires (fixtures). Transparent LED silicone encapsulant is permeable to those chemicals and they may lead to a discoloration of encapsulant when they exposed to heat or light. This phenomenon can cause a significant loss of light emitted (output) from the luminaires. In order to prevent these problems, we recommend users to know the physical properties of materials used in luminaires and they must be carefully selected.
- 11) Risk of sulfurization (or tarnishing)
 The LED from Samsung uses a silver-plated lead frame and its surface color may change to black (or dark colored) when it is exposed to sulfur (S), chlorine (Cl) or other halogen compound. Sulfurization of lead frame may cause intensity degradation, change of chromaticity coordinates and, in extreme cases, open circuit. It requires caution. Due to possible sulfurization of lead frame, LED should not be used and stored together with oxidizing substances made of materials such as rubber, plain paper, lead solder cream, etc.

Legal and additional information.

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